

FORM EKC-1449 If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee. INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		Atty. Docket No. 87260AEK Customer No. 01333		Serial No. 10/736,134	
		Applicant: Deepak Shukla, et al			
		Filing Date 15 December 2003		Group 2871 1256	

U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>h</i>	3,848,966	11-19-1974	Smith et al.			
<i>h</i>	3,894,793	07-15-1975	Haas			
<i>h</i>	3,979,319	09-07-1976	Fukai et al.			
<i>h</i>	2002/0180925	12-05-2002	Tsuboyama et al.			

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>h</i>	1 376 115	12-04-1974	GB			X
<i>h</i>	1 455 442	11-10-1976	GB			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)
--

EXAMINER <i>Shan</i>	DATE CONSIDERED <i>12/16/05</i>
-------------------------	------------------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Atty. Docket No. 87260AEK Customer No. 01333		Serial No. 10/736,134	
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee		Applicant: Deepak Shukla, et al			
		Filing Date 12/15/03		Group 1256 To Be Assigned	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					
U.S. PATENT DOCUMENTS					
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS
					FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS							
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
<i>hm</i>	2002-037777	02-06-2002	Japan			X	
<i>hm</i>	2002-038158	02-06-2002	Japan			X	
<i>hm</i>	2002-062531	02-28-2002	Japan			X	
<i>hm</i>	2002-062533	02-28-2002	Japan			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)	
<i>hm</i>	D. Shukla et al, "An Aligned Liquid Crystal Layer Containing Onium Salts and Process for Increasing the Tilt", USSN 10/736,342, (D-84415) filed 12/15/2003, <i>US 20050129875</i> .
<i>hm</i>	D. Shukla et al., "An Aligned Liquid Crystal Layer Containing Azolium Salts and Process for Increasing the Tilt", USSN 10/736,392, (D-84398) filed 12/15/2003, <i>US 20050129874</i> .

EXAMINER <i>Shukla</i>	DATE CONSIDERED 12/26/05
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	